



North America TC Chapter Flexible Hybrid Electronics Global Technical Committee

Liaison Report | February 2026

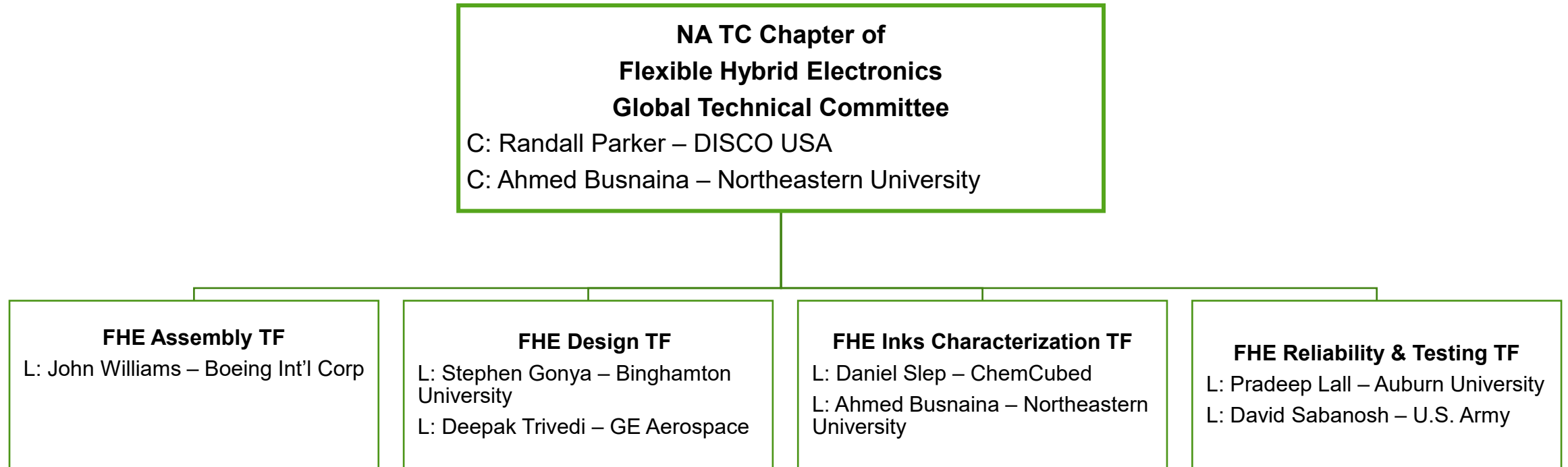
v1

STANDARDS

Meeting Information

- Last meeting
 - Tuesday, February 24, 14:00-17:00 Mountain
 - Flex Technology Summit 2026, The Wigwam Resort, Litchfield Park, Arizona
- Next meeting
 - TBD
 - May meet at ASMC 2026
- For more details, visit: <http://www.semi.org/en/standards-events>

Organization Chart



SNARF(s) Approved by GCS

(in between TC Chapter Meetings)

#	Type	SC/TF/WG	Details
7193B	SNARF Revision and Ballot Authorization	FHE Design TF	New Standard: <i>Guide for Substrate Design of Flexible Hybrid Electronics Based on Additive Printing Methods</i> , – Approved for Cycle 1-2026, by GCS on 12/12/2025

Ballot Result(s)

Doc #	Document Title	TC Chapter Action
7193B	New Standard: Guide for Substrate Design of Flexible Hybrid Electronics Based on Additive Printing Methods	Passed , with technical changes and with or without editorial changes; Ratification Ballot to be issued.

#1: **Passed** ballots and line items will be submitted to the ISC Audit & Review Subcommittee for procedural review.

#2: **Failed** ballots and line items were returned to the originating task forces for re-work and re-balloting or abandoning.

Task Force Highlights

- Publication Pending (FHE Reliability & Testing TF)
 - New Standard: Guide for Reliability of Flexible Hybrid Electronics [7242]
- Ratification Ballot to be issued (FHE Design TF)
 - New Standard: Guide for Substrate Design of Flexible Hybrid Electronics Based on Additive Printing Methods [R7193B]
- Document Under Development (FHE Inks Characterization TF)
 - 7212: Guide for Inks Characterization for Flexible Hybrid Electronics
 - Provides guidance on established tests to develop methods that pertain to reliability and testing of incoming inks. Inks in this Guide refer to all incoming printable materials, such as screen-printing pastes and ink jet inks.
- TF currently not meeting (FHE Assembly TF)
 - **Call to Action:** Looking for new co-leader(s)



THANK YOU

Staff Contact: Laura Nguyen | Lnguyen@semi.org

STANDARDS